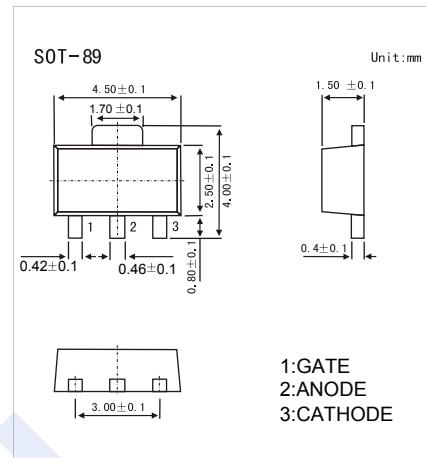


SCR Thyristor

BT169-HF (KT169-HF)

■ Features

- Repetitive peak off-state voltages :400V
- Average on-state current :0.5A
- RMS on-state current :0.8A
- Non-repetitive peak on-state current :8A
- Pb-Free Package May be Available. The G-Suffix Denotes a Pb-Free Lead Finish



■ Absolute Maximum Ratings Ta = 25°C

Parameter	Symbol	Rating	Unit
Peak Repetitive Forward and Reverse Blocking Voltages BT169-400-HF	V _{DRM} V _{RRM}	400	V
Average on-state Current	I _{T(AV)}	0.5	A
Forward Current RMS	I _{T(RMS)}	0.8	
Non-Repetitive Peak on-state Current (t=10ms)	I _{TSM}	8	
Non-Repetitive Peak on-state Current (t=8.3ms)		9	
Circuit Fusing Considerations (t = 10ms)	I ² t	0.32	A ² s
Repetitive Rate of rise of on-state Current after Triggering	dI _T /dt	50	A/us
Peak Gate Current	I _{GM}	1	A
Peak Gate Voltage	V _{GM}	5	V
Peak Gate Voltage — Reverse	V _{GRM}	5	
Peak Gate Power — Forward	P _{GM}	2	W
Average Gate Power — Forward	P _{GF(AV)}	0.1	
Thermal Resistance Junction to Ambient	R _{thJA}	150	K/W
Thermal Resistance Junction to Case	R _{thJC}	60	
Junction Temperature	T _J	125	°C
Storage Temperature Range	T _{stg}	-40 to 150	

SCR Thyristor

BT169-HF (KT169-HF)

■ Electrical Characteristics ($T_a = 25^\circ\text{C}$, unless otherwise noted.)

Parameter	Symbol	Test Conditions	Min	Typ.	Max	Unit
Peak Repetitive Forward and Reverse Blocking Voltages	V_{DRM} V_{RRM}	$I_{DRM}=I_{RRM}50\mu\text{A}$	400			V
Off-state Leakage Current	I_D, I_R	$V_{DRM}=V_{RRM}(\text{max}); T_j=125^\circ\text{C}; R_{GK}=1\text{k}\Omega$			0.1	mA
On-state Voltage	V_T	$I_T=1\text{A}$			1.5	
Gate Trigger Voltage	V_{GT}	$V_D=12\text{V}, I_T=10\text{mA}$			0.8	V
		$V_D= V_{DRM}(\text{max}), I_T=10\text{mA}; T_j=125^\circ\text{C}$	0.2			
Gate Trigger Current (Continuous dc)	I_{GT}	$V_D=12\text{V}, I_T=10\text{mA}$			200	uA
Latching Current	I_L	$V_D=12\text{V}, I_{GT}=0.5\text{mA}; R_{GK}=1\text{k}\Omega$			6	mA
Holding Current	I_H	$V_D=12\text{V}, I_{GT}=0.5\text{mA}; R_{GK}=1\text{k}\Omega$			5	
Critical Rate of rise of off-state Voltage	dV/dt	$V_{DM}=67\% V_{DRM}(\text{max}); T_j=125^\circ\text{C}$ exponential waveform; $R_{GK}=1\text{k}\Omega$		25		V/us
Gate Controlled turn-on time	t_{gt}	$I_{TM}=2\text{A}; V_D=V_{DRM}(\text{max}), G=10\text{mA};$ $dI_G/dt=0.1\text{A/us}$		2		us
Circuit Commutated turn-off time	t_q	$V_D=67\% V_{DRM}(\text{max}); T_j=125^\circ\text{C},$ $T_M=1.6\text{A}; V_R=35\text{V};$ $dI_M/dt=30\text{A/us}, dV/dt=2\text{V/us}; R_{GK}=1\text{k}\Omega$		100		

■ Classification of I_{GT} (uA)

Type	BT169-400-HF	BT169-400A-HF	BT169-400B-HF
Range	0-200	10-30	30-60
Marking	BT/C39 F	BT/C35 F	BT/C36 F

SCR Thyristor

BT169-HF (KT169-HF)

■ Typical Characteristics

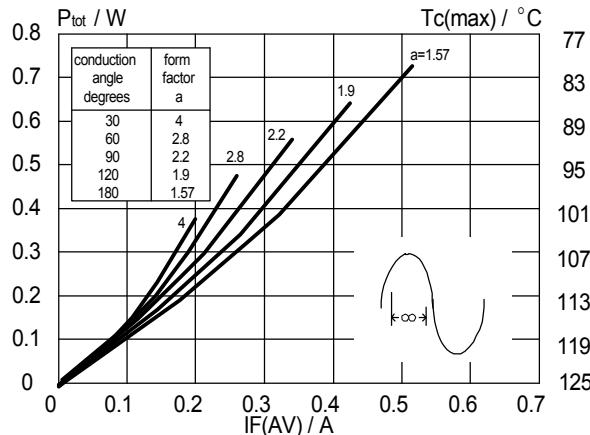


FIG.1 Maximum on-state dissipation, P_{tot} , versus average on-state current, $I_{(AV)}$, where a =form factor= $I_{T(RMS)} / I_{(AV)}$

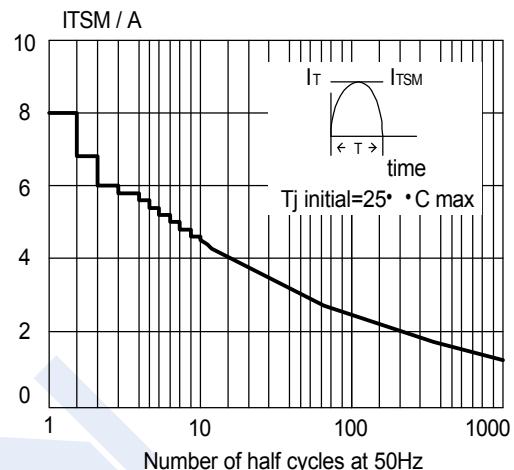


FIG.4 Maximum permissible non-repetitive peak on-state current I_{TSM} , versus number of cycles, for sinusoidal currents, $f = 50\text{Hz}$.

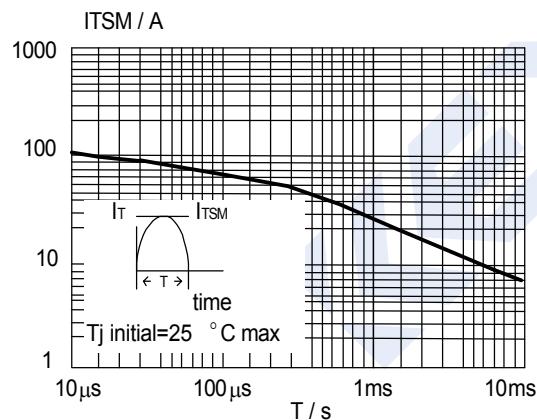


FIG.2 Maximum permissible non-repetitive peak on-state current I_{TSM} , versus pulse width t_p , for sinusoidal currents, $t_p \leq 10\text{ms}$.

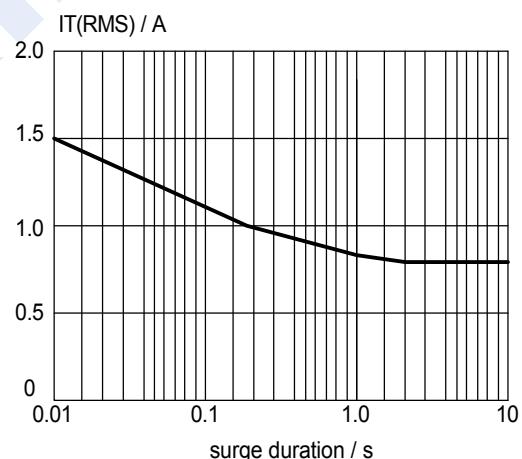


FIG.5 Maximum permissible repetitive rms on-state current $I_{T(RMS)}$, versus surge duration, for sinusoidal currents, $f = 50\text{Hz}$; $T_{lead} \leq 83^\circ\text{C}$

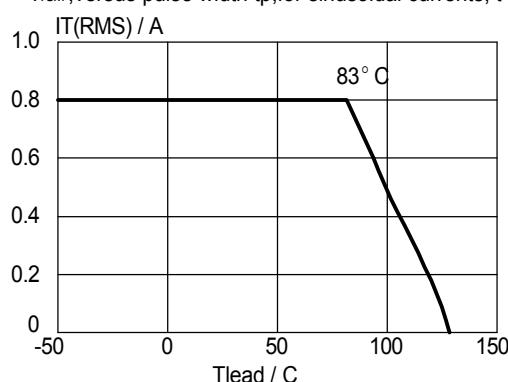


FIG.3 Maximum permissible rms current $I_{T(RMS)}$, versus lead temperature, T_{lead}

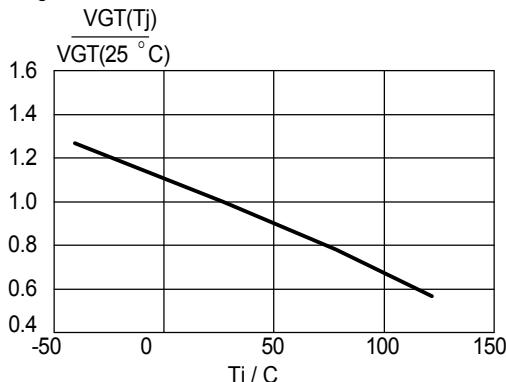


FIG.6 Normalised gate trigger voltage $V_{GT}(Tj) / V_{GT}(25^\circ\text{C})$, versus junction temperature Tj

SCR Thyristor

BT169-HF (KT169-HF)

■ Typical Characteristics

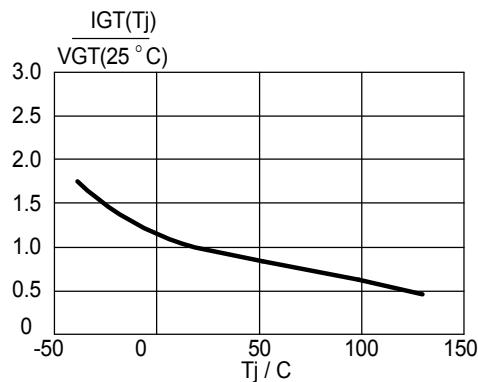


FIG.7 Normalised gate trigger current $I_{GT}(T_j)/I_{GT}(25^\circ C)$, versus junction temperature T_j

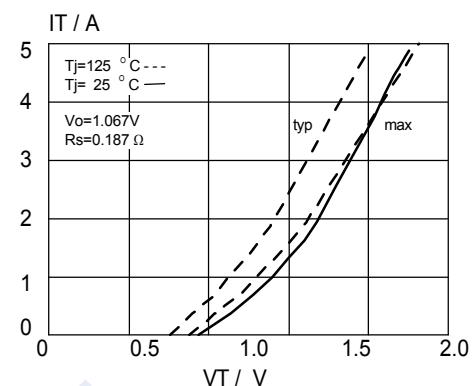


FIG.10 Typical and maximum on-state characteristic.

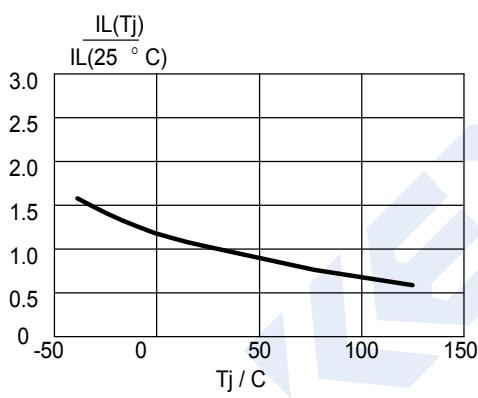


FIG.8 Normalised latching current $I_L(T_j)/I_L(25^\circ C)$, versus junction temperature T_j , $R_{GK} = 1\Omega$

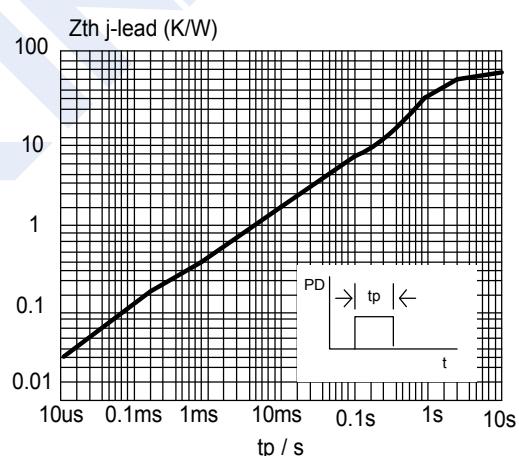


FIG.11 Transient thermal impedance $Z_{th} \text{ j-lead }$, versus pulse width t_p .

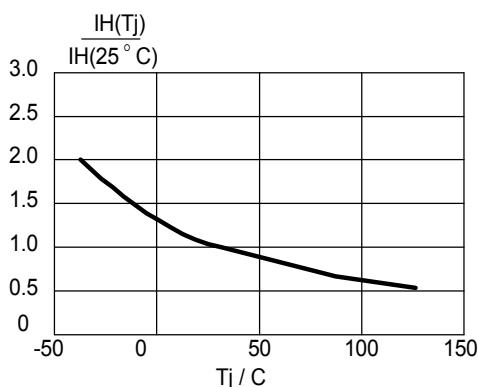


FIG.9 Normalised holding current $I_H(T_j)/I_H(25^\circ C)$, versus junction temperature T_j , $R_{GK} = 1\Omega$

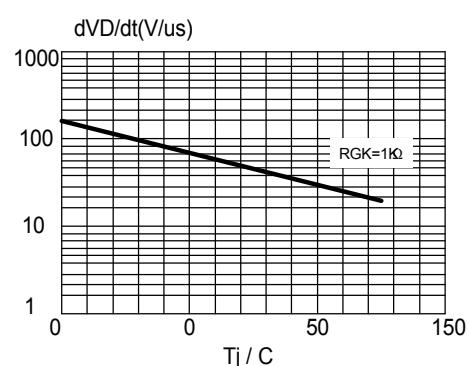


FIG.12 Typical, critical rate of rise of off-state voltage, dV/dt versus junction temperature T_j .